

FORM PTO 1449 (modified)

U.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICELIST OF REFERENCES CITED BY APPLICANT(S)  
(Use several sheets if necessary)ATTY DOCKET NO.  
**35.G2544**APPLICATION NO.  
**09/519,672**APPLICANT  
**TOSHIHIKO OUCHI ET AL.**FILING DATE  
**March 6, 2000**GROUP  
**2879**

## U.S. PATENT DOCUMENTS

*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
<i>CS</i>	<b>5294790</b>	<b>3/94</b>	<b>Ohta et al.</b>	<b>250</b>	<b>216</b>	

## FOREIGN PATENT DOCUMENTS

	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT
<i>CS</i>	<b>JP 5-100168</b>	<b>4/93</b>	<b>Japan</b>			<b>Abstract of USP 5294790</b>
<i>CS</i>	<b>JP 8-306062</b>	<b>11/96</b>	<b>Japan</b>			<b>Abstract</b>

## OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)

<i>CS</i>	<b>U. Dürig et al., "Near-field optical-scanning microscopy ", J. Appl. Phys. 59 (10) May 1986, pp. 3318-3327.</b>

EXAMINER

*Courtney Thomas*

DATE CONSIDERED

**03.10.02**

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Sheet 1 of 1RECEIVED  
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